

TENTATIVE

# CUS01

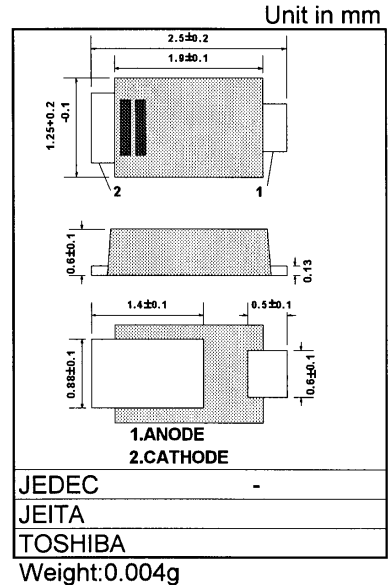
Portable equipment battery application

- Forward Voltage :  $V_{FM}=0.37V(\text{max})$
- Average Forward Current :  $I_{F(AV)}=0.7A$
- Repetitive Peak Reverse Voltage :  $V_{RRM}=30V$
- Small & Thin package " US-FLAT™ "(Toshiba package name)

Maximum Ratings( $T_a=25^\circ C$ )

Characteristics	Symbol	Rating	Unit
Repetitive Peak Reverse Voltage	$V_{RRM}$	30	V
Average Forward Current	$I_{F(AV)}$	0.7(Note)	A
Peak one Cycle Surge Forward Current	$I_{FSM}$	20(50Hz)	A
Junction Temperature	$T_j$	-40 ~ 125	°C
Storage Temperature Range	$T_{stg}$	-40 ~ 150	°C

Note:  $Tl=92^\circ C$ :Rectangular waveform( $\alpha=180^\circ$ ),  $V_R=15V$

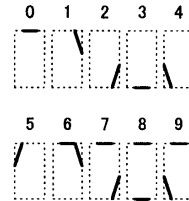
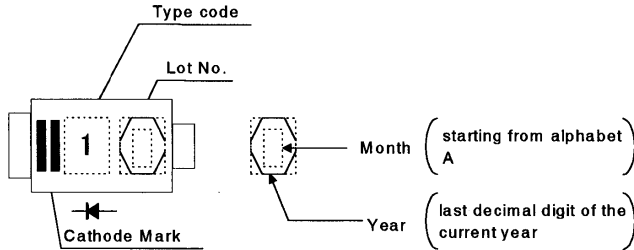


Electrical Characteristics ( $T_a=25^\circ C$ )

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Peak Forward Voltage	$V_{FM(1)}$	$I_{FM}=0.1A$	-	0.25	-	V
	$V_{FM(2)}$	$I_{FM}=0.3A$	-	0.29	-	
	$V_{FM(3)}$	$I_{FM}=0.7A$	-	0.33	0.37	
Repetitive Peak Reverse Current	$I_{RRM(1)}$	$V_{RRM}=5V$	-	50	-	uA
	$I_{RRM(2)}$	$V_{RRM}=30V$	-	0.5	1.5	mA
Junction Capacitance	$C_j$	$V_R=10V, f=1.0MHz$	-	40	-	pF
Thermal Resistance	$R_{th(j-a)}$	On ceramic substrate (Soldering Land 2mm×2mm)	-	-	75	°C/W
		On glass-epoxy substrate (Soldering Land 6mm×6mm)	-	-	150	
	$R_{th(j-l)}$	Junction to lead of cathode side	-	-	30	

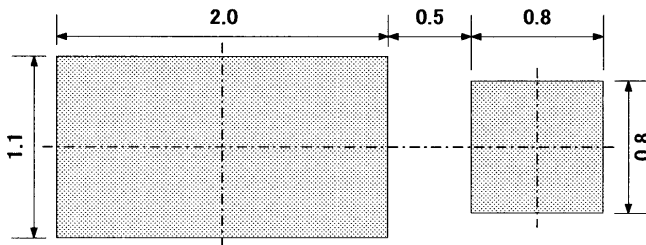
**Marking**

Following Indicates the Data of Manufacture



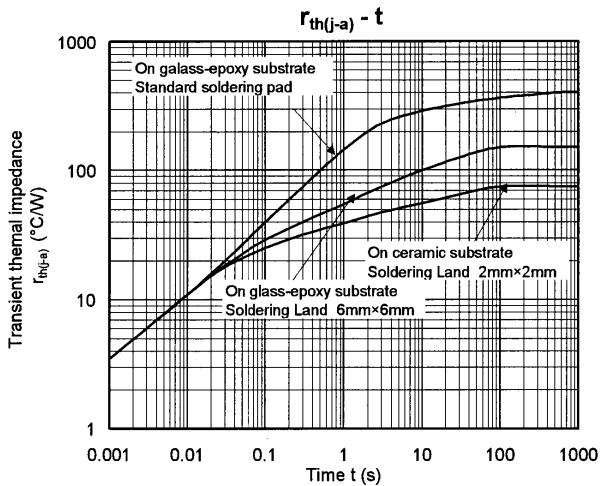
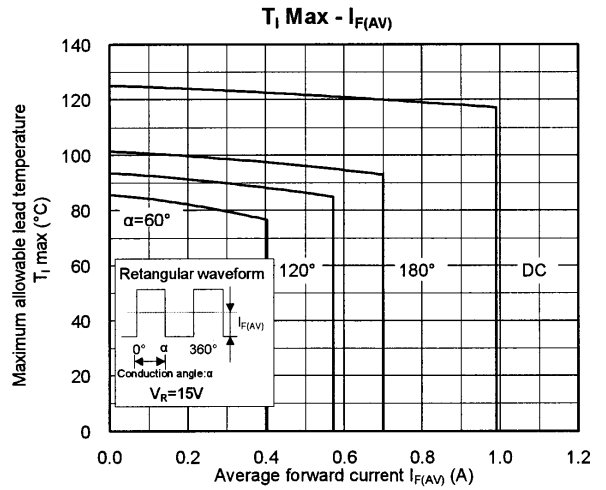
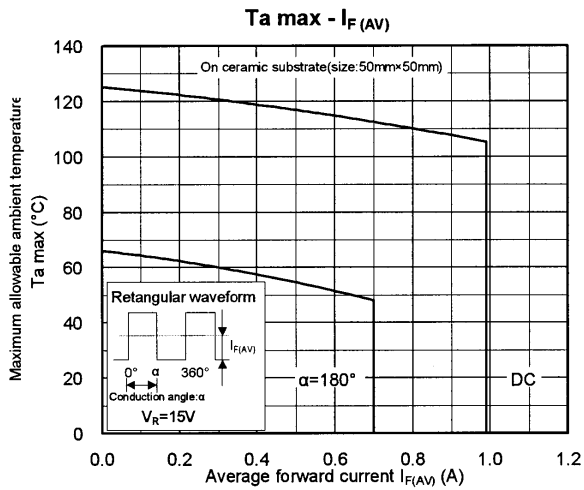
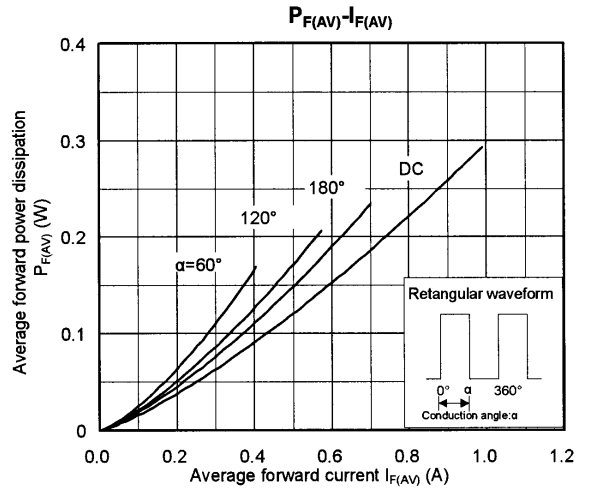
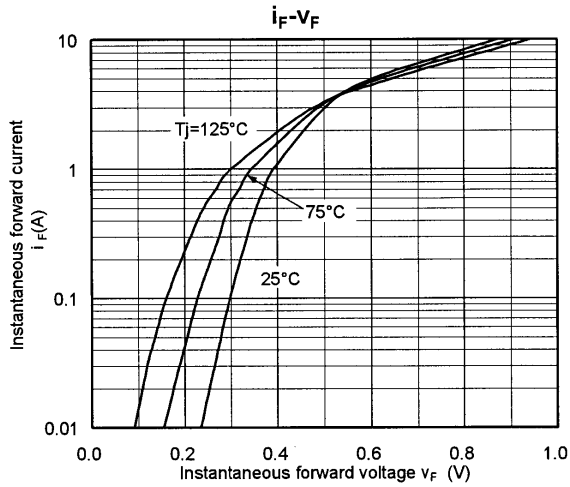
**Standard Soldering Pad**

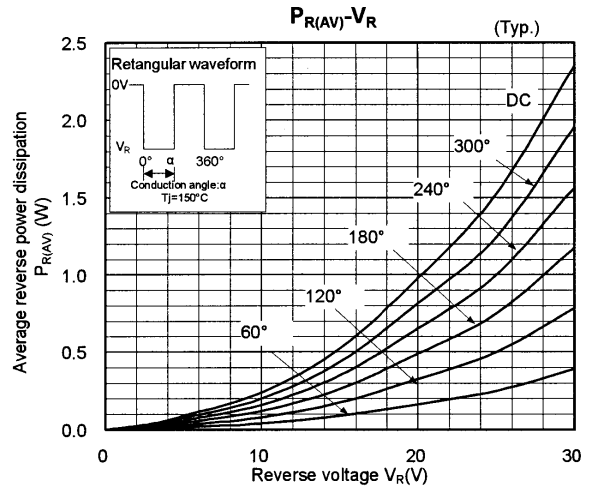
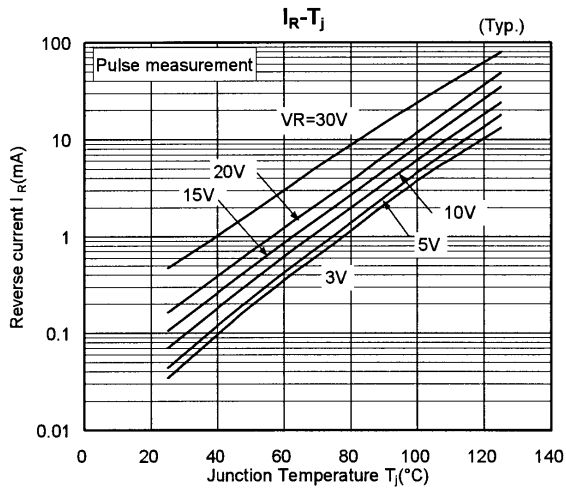
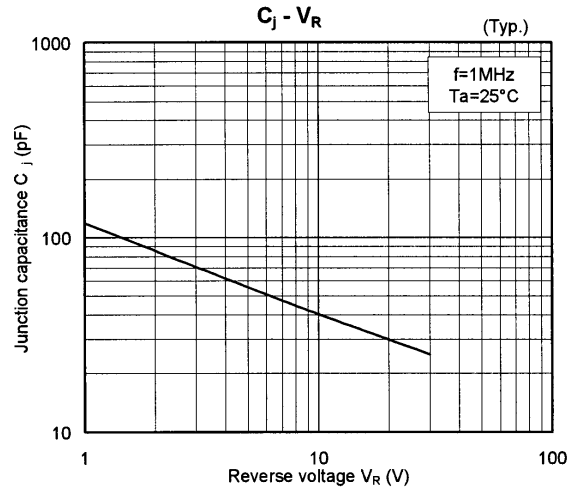
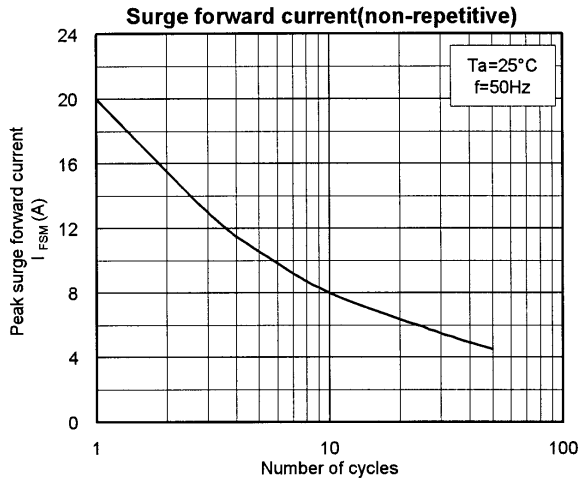
Unit in mm



**Handling Precaution**

Schottky barrier diodes are having large reverse current leakage characteristic compare to the other rectifier products. This current leakage and not proper operating temperature or voltage may cause thermal runaway. Please take forward and reverse loss into consideration when you design.





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